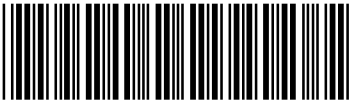


**Search Notes**

Application/Control No.

10/600,853

Examiner

/Yonel Beaulieu/

Applicant(s)/Patent under  
Reexamination

LICH ET AL.

Art Unit

3661

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
Int. Search		5/5/2008	YB

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
WEST+Int.+Fwd/Bwd	5/5/2008	YB